Form PTO-1449 Sheet 1 of 2
Applicant: Yuichi Akage et al. Confirmation No.: 5766

 Applicant:
 Yuichi Akage et al.
 Confirmation No.; 5766

 Serial No.:
 10/576,627
 Att'y Docket No.; 14321.83

 Filing Date
 April 21, 2006
 Art Unit; 2873

ELECTRODE PAD ON CONDUCTIVE SEMICONDUCTOR SUBSTRATE

INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANT

U.S. Patent Documents

Examiner	Document	Issue	
Initial*	Number	Date	Name

Foreign Patent Documents

Examiner Initial*	Document Number	Publication Date	Country or Patent Office	Translation
1	06-013438	01/21/1994	Japan	No
2	2003-023010	01/24/2003	Japan	No

Other Documents

(including author, title, pertinent pages, etc.)

Examiner Initial*

For:

3 M.N. Khan et al., Theoretical Prediction and Experimental Verification of Quantum Well Electroabsorption Modulators with Bandwidths Exceeding 40 GHz, OFC99, paper ThT4-1/293.

Examiner: Date Considered:

Form PTO-1449 Sheet 2 of 2
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References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Pattern Examining Procedure and 37 C.F.R. § § 19 and 1.9. To be considered a proper Information Disclosure Statement, Form FTO-1409 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the perturben portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a finely ransurer as set out in MPEP Sec. of the Medicant Processing Section 1997.

Examiners will consider all estations submitted in conformance with 37 C.F.R. § 1.98 and MPEP Sec. 609 and place their initials adjacent the chations in the spaces provided on this form. Examiners will also initial estations not in conformance with the guidelines which may have been considered. A reference may be considered by the Examiner for any reason whether or not the clatation is in full conformance with the guidelines. A line will be drawn through a clatation fit is not in conformance with the quidelines AND has not been considered. A copy of the submitted form, as rough the through a clatation fit is not in conformance with the quidelines AND has not been considered. A copy of the submitted form, as rought with the next communication. The original of the form will be entered into the analysiston file.

Each citation initialed by the Examiner will be printed on the issued patent in the same manner as references cited by the Examiner on Form PTO-892.

The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTA-1142

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For:

Examiner: Date Considered: